

International Conference on

Applied Physics & Laser, Optics and Photonics

April 15-16, 2019 | Frankfurt, Germany

Some critical problems of the physical design and performance of electronic and optical materials, assemblies and systems: Application of analytical modelling

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C ome critical problems of the mechanical **J**behavior and performance of electronic and optical materials, assemblies and systems are addressed and discussed. It is shown that application of analytical modeling (always confirmed by finite-element-analyses) enables to reveal and explain the underlying physics associated with such, often non-obvious, always non-trivial and sometime even paradoxical, problems. Some of the addressed problems are: interfacial thermal stresses in adhesively bonded or soldered assemblies and application of inhomogeneous attachments for lower thermal stresses; thermal and lattice mismatch stresses in semiconductor crystal grown assemblies; dynamic response of electronic systems to shocks and vibrations; stress relief in solder joints owing to their elevated stand-off heights; using inhomogeneous solder joint systems for lower thermal stresses;

thermal stress in flexible electronics; incentive for mechanical pre-stressing of accelerated test specimens subjected to thermal loading; stress relief in thermoelectric module designs using thinner and longer legs; low-temperature microbending of long-haul dual-coated optical fibers; two-point bending of optical fiber specimens. It is concluded that while all the three basic approaches in microelectronics and photonics materials science and engineering - analytical (mathematical) modeling, numerical modeling (simulation) and experimental investigations - are equally important in understanding the physics of the materials behavior and in designing, on this basis, viable and reliable electronic devices and products, analytical modeling occupies a special place owing to its ability to provide clear and concise information of the problems it addresses.

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